

## **Model sNIP** Normal Incidence Pyrheliometer

A pyrheliometer mounted on a solar tracker is used to measure the Direct Normal Solar Irradiance (DNI) from the sun. Historically, the preferred field of view for Pyrheliometers was based on a 10:1 ratio which equated to approximately 5.7°. Due in part to the commercialization of the Eppley AHF Cavity Radiometer as a Primary Standard and advances in accuracy of Automatic Solar Trackers (such as GEONICA SunTrackers 2000/3000) the preferred FOV for pyrheliometers is now 5° which the Eppley sNIP uses. In fact, the sNIP has the exact same geometric dimensions as used in the AHF. Compared to the older NIP, the sNIP also has a faster response time, reduced conduction and convection effects and a thermistor is included for those who wish to measure the instrument temperature.

As a result, the Normal Incidence Pyrheliometer, Model sNIP meets the performance specifications of an ISO Secondary Standard\* and a WMO High Quality Pyrheliometer.

\* To officially be considered a Secondary Standard, the pyrheliometer in question must be calibrated with WRR traceability through a Primary Standard Pyrheliometer such as the Eppley AHF Cavity Radiometer. EPLAB Calibrations are typically performed against a Secondary Standard Pyrheliometer. At the customer's request and for an additional fee, this calibration can be performed against our WRR traceable AHF Cavity Radiometer. Please contact Eppley for additional information.

\*\* There has been much discussion on "uncertainty" and how it pertains to solar measurements. The RSS of the 9060 specifications results in an uncertainty of approximately 1.5%. The typical uncertainty of Eppley's factory calibrations are less than 1%. The stated uncertainty of the WRR is 0.4%. Evidence from direct comparisons of sNIP to AHF show the sNIP is capable of hourly and daily averages better than 1% (assuming proper tracking and clean windows).



## SPECIFICATIONS

| Application               | Standard/Network Measurements      |
|---------------------------|------------------------------------|
| Classification            | Secondary Standard* / High Quality |
| Traceability              | World Radiation Reference (WRR)    |
| Spectral Range            | 250-3500 nm                        |
| Field of View             | 5°                                 |
| Output                    | 0-10 mV analog                     |
| Sensitivity               | approx. 8 µV / Wm <sup>-2</sup>    |
| Impedance                 | approx. 200 $\Omega$               |
| 95% Response Time         | 5 seconds                          |
| Zero Offset               | 1 Wm <sup>-2</sup>                 |
| Non-Stability             | 0.5%                               |
| Non-Linearity             | 0.2%                               |
| Spectral Selectivity      | 0.5%                               |
| Temperature Response      | 0.5%                               |
| Calibration Uncertainty** | < 1%                               |
| Measurement Uncertainty** |                                    |
| Single Point              | < 5 Wm <sup>-2</sup>               |
| Hourly Average            | approx. 1%                         |
| Daily Average             | approx. 1%                         |